

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/617,690	TANAKA ET AL.
Examiner	Art Unit	
William J. Deane	2614	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
379	433.13	3050p06	mf
455	575.3	↓	↓